TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# **TC74VCXR162245FT**

#### Low-Voltage 16-Bit Bus Transceiver with 3.6-V Tolerant Inputs and Outputs

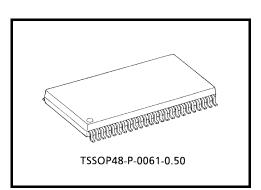
The TC74VCXR162245FT is a high-performance CMOS 16-bit bus transceiver. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to  $3.6\ V.$ 

This 16 bit bus transceiver is controlled by direction control (DIR) inputs and output enable  $(\overline{OE})$  inputs which are common to each byte. It can be used as two 8-bit transceivers or one 16-bit transceiver. The direction of data transmission is determined by the level of the DIR inputs. The  $\overline{OE}$  inputs can be used to disable the device so that the busses are effectively isolated.

The  $26 \cdot \Omega$  series resistor helps reducing output overshoot and undershoot without external resistor.

All inputs are equipped with protection circuits against static discharge.



Weight: 0.25 g (typ.)

#### Features (Note)

- $26-\Omega$  series resistors on all outputs
- Low-voltage operation: V<sub>CC</sub> = 1.8 to 3.6 V
- High-speed operation:  $t_{pd} = 3.4 \text{ ns (max) (V}_{CC} = 3.0 \text{ to } 3.6 \text{ V)}$

 $t_{pd} = 4.3 \text{ ns (max) (VCC} = 2.3 \text{ to } 2.7 \text{ V}$ 

 $t_{pd} = 5.7 \text{ ns (max) (V}_{CC} = 1.8 \text{ V})$ 

• utput current:  $I_{OH}/I_{OL} = \pm 12 \text{ mA (min)} (V_{CC} = 3.0 \text{ V})$ 

 $: I_{OH}/I_{OL} = \pm 8 \text{ mA (min) (V}_{CC} = 2.3 \text{ V)}$ 

 $: I_{OH}/I_{OL} = \pm 4 \text{ mA (min) (V}_{CC} = 1.8 \text{ V)}$ 

- Latch-up performance: ±300 mA
- ESD performance: Machine model > ±200 V

: Human body model  $> \pm 2000 \text{ V}$ 

- Package: TSSOP (thin shrink small outline package)
- Bidirectional interface between 2.5 V and 3.3 V signals.
- 3.6-V tolerant function and power-down protection is provided on all inputs and outputs

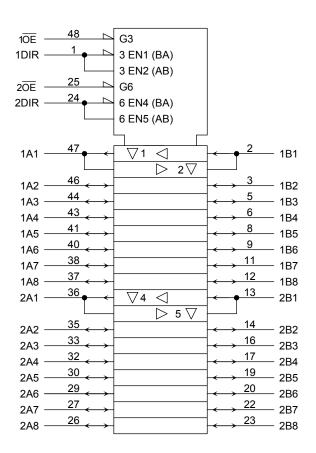
Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

All floating (high impedance) bus pins must have their input level fixed by means of pull-up or pull-down resistors.

#### Pin Assignment (top view)

#### 10E 1DIR 48 2 47 1B1 1A1 3 1B2 1A2 46 GND 4 **GND** 45 5 1B3 1A3 1B4 6 43 1A4 $V_{CC}$ 7 42 $V_{CC}$ 1B5 8 1A5 41 1B6 9 1A6 40 GND 10 **GND** 39 1B7 11 38 1A7 1B8 12 37 1A8 2B1 13 36 2A1 2B2 14 35 2A2 GND 15 GND 34 2B3 16 33 2A3 2B4 17 32 2A4 V<sub>CC</sub> 18 31 $V_{CC}$ 2B5 19 2A5 30 2B6 20 29 2A6 GND 21 28 **GND** 2B7 22 27 2A7 2B8 23 26 2A8 2DIR 24 2OE 25

#### **IEC Logic Symbol**



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# **Truth Table**

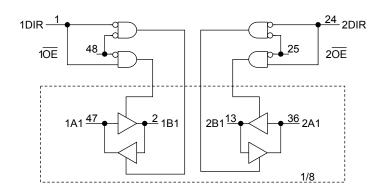
Inp	Inputs Function		Function		
1OE	1DIR	Bus 1A1-1A8	Bus 1B1-1B8	Outputs	
L	L	Output	Input	A = B	
L	Н	Input	Output	B=A	
Н	Х	Z		Z	

Inp	uts	Fun		
2 <del>OE</del>	2DIR	BUS 2A1-2A8	BUS 2B1-2B8	Outputs
L	L	Output	Input	A = B
L	Н	Input	Output	B=A
Н	Х	-	Z	

X: Don't care

Z: High impedance

# **System Diagram**



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# **Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	-0.5 to 4.6	V
DC input voltage (DIR, $\overline{\text{OE}}$ )	V <sub>IN</sub>	-0.5 to 4.6	V
		-0.5 to 4.6 (Note 2)	
DC bus I/O voltage	V <sub>I/O</sub>	-0.5 to V <sub>CC</sub> + 0.5	V
		(Note 3)	
Input diode current	I <sub>IK</sub>	-50	mA
Output diode current	lok	±50 (Note 4)	mA
DC output current	lout	±50	mA
Power dissipation	$P_{D}$	400	mW
DC V <sub>CC</sub> /ground current per supply pin	I <sub>CC</sub> /I <sub>GND</sub>	±100	mA
Storage temperature	T <sub>stg</sub>	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Note 2: OFF state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4:  $V_{OUT} < GND, V_{OUT} > V_{CC}$ 

#### **Recommended Operating Range (Note 1)**

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V <sub>CC</sub>	1.8 to 3.6	V	
Tower supply voltage	VCC	1.2 to 3.6 (Note 2)	V	
Input voltage (DIR, $\overline{OE}$ )	V <sub>IN</sub>	-0.3 to 3.6	٧	
Puo I/O voltago	Viva	0 to 3.6 (Note 3)	V	
Bus I/O voltage	V <sub>I/O</sub>	0 to V <sub>CC</sub> (Note 4)	V	
		±12 (Note 5)		
Output current	I <sub>OH</sub> /I <sub>OL</sub>	±8 (Note 6)	mA	
		±4 (Note 7)		
Operating temperature	T <sub>opr</sub>	–40 to 85	°C	
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V	

Note 1: The recommended operating conditions are required to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Note 2: Data retention only

Note 3: OFF state

Note 4: High or low state

Note 5:  $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$ 

Note 6:  $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$ 

Note 7:  $V_{CC} = 1.8 \text{ V}$ 

Note 8:  $V_{IN} = 0.8$  to 2.0 V,  $V_{CC} = 3.0$  V



#### **Electrical Characteristics**

# DC Characteristics (Ta = -40 to $85^{\circ}$ C, 2.7 V < $V_{CC} \le 3.6$ V)

Character	istics	Symbol	Test Condition			Min	Max	Unit			
					V <sub>CC</sub> (V)						
Input voltage	H-level	V <sub>IH</sub>	-		2.7 to 3.6	2.0	_	V			
input voltage	L-level	V <sub>IL</sub>	-	_	2.7 to 3.6		0.8	V			
				$I_{OH} = -100 \mu A$	2.7 to 3.6	V <sub>CC</sub> - 0.2	_				
	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	$I_{OH} = -6 \text{ mA}$	2.7	2.2	_				
				$I_{OH} = -8 \text{ mA}$	3.0	2.4	_				
Output voltage				$I_{OH} = -12 \text{ mA}$	3.0	2.2	_	V			
		Va. Va	OL VIN = VIH or VIL	I <sub>OL</sub> = 100 μA	2.7 to 3.6	_	0.2				
	L-level			I <sub>OL</sub> = 6 mA	2.7	_	0.4				
	L-ievei	VOL		AIN = AIH OI AIL	AIN — AIH OI AIT	AIN — AIH OI AIL	I <sub>OL</sub> = 8 mA	3.0	_	0.55	
				I <sub>OL</sub> = 12 mA	3.0	_	0.8				
Input leakage curre	ent	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.7 to 3.6	_	±5.0	μА			
2 -1-1	-1-11	loz	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$			140.0	^			
3-state output OFF	3-state output OFF state current		$V_{OUT} = 0$ to 3.6 V		2.7 to 3.6		±10.0	μΑ			
Power-off leakage	current	l <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	_	10.0	μА			
Outro and supply supply		1	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.7 to 3.6	_	20.0				
Quiescent supply of	urrent	Icc	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.$	6 V	2.7 to 3.6	_	±20.0	μΑ			
Increase in I <sub>CC</sub> per	input	Δlcc	V <sub>IH</sub> = V <sub>CC</sub> - 0.6 V		2.7 to 3.6		750				

# DC Characteristics (Ta = -40 to 85°C, 2.3 V $\leq$ V<sub>CC</sub> $\leq$ 2.7 V)

Character	ristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit							
Innut voltage	H-level	V <sub>IH</sub>		_	2.3 to 2.7	1.6	_	V							
Input voltage	L-level	V <sub>IL</sub>		_	2.3 to 2.7	_	0.7	V							
				I <sub>OH</sub> = -100 μA	2.3 to 2.7	V <sub>CC</sub> - 0.2	_								
	H-level	VoH	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -4 mA	2.3	2.0	_								
					=						$I_{OH} = -6 \text{ mA}$	2.3	1.8	_	
Output voltage				$I_{OH} = -8 \text{ mA}$	2.3	1.7	_	V							
			$V_{IN} = V_{IH}$ or $V_{IL}$	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	$V_{OL}$ $V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OL} = 100 \ \mu A$	2.3 to 2.7	_	0.2			
	L-level	V <sub>OL</sub>							$V_{IN} = V_{IH}$ or $V_{IL}$	$V_{IN} = V_{IH} \ or \ V_{IL}$	I <sub>OL</sub> = 6 mA	2.3	_	0.4	
				I <sub>OL</sub> = 8 mA	2.3	_	0.6								
Input leakage curre	ent	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.3 to 2.7	_	±5.0	μА							
2 state sutput OFF	otata aurrant	1	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>		0.2 to 0.7		110.0	^							
3-state output OFF state current		loz	$V_{OUT} = 0$ to 3.6 V		2.3 to 2.7		±10.0	μΑ							
Power-off leakage	current	l <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	_	10.0	μА							
0		laa	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.3 to 2.7	_	20.0								
Quiescent supply of	unent	Icc	$V_{CC} \le (V_{IN}, V_{OUT}) \le$	3.6 V	2.3 to 2.7	_	±20.0	μΑ							

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# DC Characteristics (Ta = -40 to $85^{\circ}$ C, $1.8 \text{ V} \leq \text{V}_{\text{CC}} < 2.3 \text{ V}$ )

Characteris	stics	Symbol	Test Condition		Vac (V)	Min	Max	Unit
					V <sub>CC</sub> (V)			
Input voltage	H-level	$V_{IH}$	_	_	1.8 to 2.3	0.7 × V <sub>CC</sub>	_	V
input voitage	L-level	V <sub>IL</sub>	_	_	1.8 to 2.3		0.2 × V <sub>CC</sub>	V
	H-level	Voh	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	1.8	V <sub>CC</sub> - 0.2	١	
Output voltage				$I_{OH} = -4 \text{ mA}$	1.8	1.4		V
	L-level	\/-·	Ver Ver on Ver	I <sub>OL</sub> = 100 μA	1.8	_	0.2	
	L-level	V <sub>OL</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OL</sub> = 4 mA	1.8	_	0.3	
Input leakage currer	nt	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		1.8	_	±5.0	μΑ
2 state subsut OFF		loz	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>			110.0	^
3-state output OFF s	3-state output OFF state current		$V_{OUT} = 0$ to 3.6 V		1.8		±10.0	μΑ
Power-off leakage c	urrent	I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	_	10.0	μА
Quiescent supply of			V <sub>IN</sub> = V <sub>CC</sub> or GND		1.8	_	20.0	^
Quiescent supply cu	iiieiii	Icc	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6 \text{ V}$		1.8	_	±20.0	μА

# AC Characteristics (Ta = -40 to 85°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF, $R_L = 500~\Omega$ ) (Note 1)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
			1.8	1.5	5.7	
Propagation delay time	t <sub>pLH</sub>	Figure 1, Figure 2	$2.5\pm0.2$	1.0	4.3	ns
	t <sub>pHL</sub>		$3.3 \pm 0.3$	8.0	3.4	
	+		1.8	1.5	7.6	
3-state output enable time	t <sub>pZL</sub> t <sub>pZH</sub>	Figure 1, Figure 3	$2.5 \pm 0.2$	1.0	5.7	ns
			$3.3 \pm 0.3$	8.0	4.2	
	4			1.5	5.7	
3-state output disable time	t <sub>pLZ</sub>	Figure 1, Figure 3	$2.5\pm0.2$	1.0	4.8	ns
	t <sub>pHZ</sub>		$3.3 \pm 0.3$	8.0	4.1	
	•		1.8	_	0.5	
Output to output skew	t <sub>osLH</sub> t <sub>osHL</sub>	(Note 2)	$2.5 \pm 0.2$	_	0.5	ns
			$3.3 \pm 0.3$	_	0.5	

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Note 1: For  $C_L = 50 \ pF$ , add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.  $(t_{OSLH} = |t_{DLHm} - t_{DLHn}|, \, t_{OSHL} = |t_{DHLm} - t_{DHLn}|)$ 



# Dynamic Switching Characteristics (Ta = 25°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF)

Characteristics	Symbol	Test Condition	Ī	V <sub>CC</sub> (V)	Тур.	Unit
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (N	lote)	1.8	0.15	
Quiet output maximum dynamic V <sub>OI</sub>	V <sub>OLP</sub>	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (N	lote)	2.5	0.25	V
, 01		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (N	lote)	3.3	0.35	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (N	lote)	1.8	-0.15	
Quiet output minimum dynamic V <sub>OI</sub>	V <sub>OLV</sub>	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (N	lote)	2.5	-0.25	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (N	lote)	3.3	-0.35	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (N	lote)	1.8	1.55	
Quiet output minimum dynamic V <sub>OH</sub>	0	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (N	lote)	2.5	2.05	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (N	lote)	3.3	2.65	

Note: Parameter guaranteed by design.

#### **Capacitive Characteristics (Ta = 25°C)**

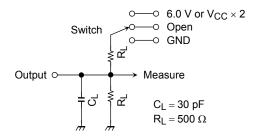
Characteristics	Symbol	Test Condition			Тур.	Unit
Characteristics	Syllibol			V <sub>CC</sub> (V)	ιyp.	Offic
Input capacitance	C <sub>IN</sub>	_		1.8, 2.5, 3.3	6	pF
Bus I/O capacitance	C <sub>I/O</sub>	_		1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C <sub>PD</sub>	f <sub>IN</sub> = 10 MHz	(Note)	1.8, 2.5, 3.3	20	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/16 \text{ (per bit)}$ 

#### **AC Test Circuit**



Parameter	Switch			
t <sub>pLH</sub> , t <sub>pHL</sub>	Open			
t <sub>pLZ</sub> , t <sub>pZL</sub>	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$			
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND			

Figure 1

#### **AC Waveform**

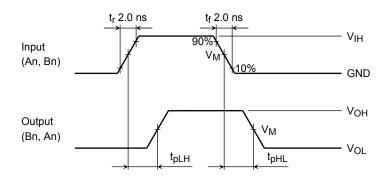


Figure 2  $t_{pLH}$ ,  $t_{pHL}$ 

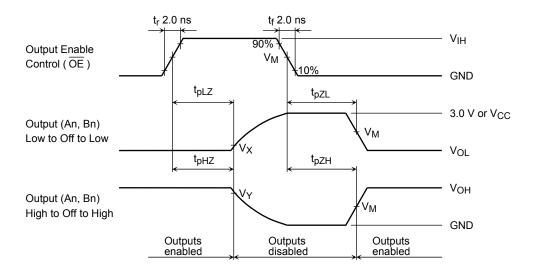


Figure 3  $t_{\text{pLZ}},\,t_{\text{pHZ}},\,t_{\text{pZL}},\,t_{\text{pZH}}$ 

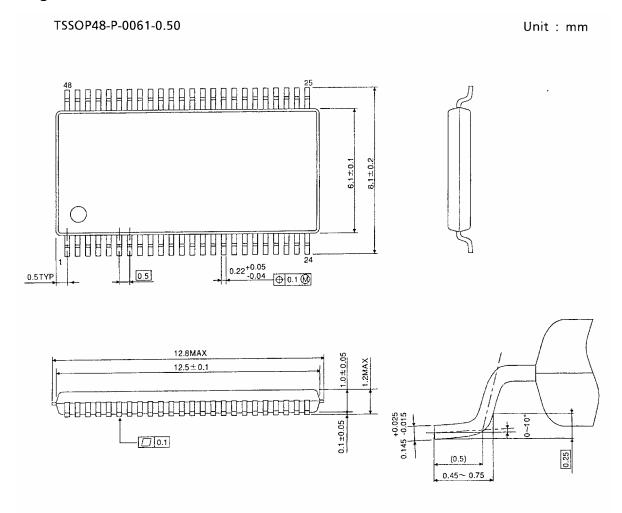
Symbol	Vcc						
Symbol	$3.3\pm0.3~\textrm{V}$	$2.5\pm0.2\textrm{V}$	1.8 V				
V <sub>IH</sub>	2.7 V	V <sub>CC</sub>	V <sub>CC</sub>				
V <sub>M</sub>	1.5 V	V <sub>CC</sub> /2	V <sub>CC</sub> /2				
VX	V <sub>OL</sub> + 0.3 V	V <sub>OL</sub> + 0.15 V	V <sub>OL</sub> + 0.15 V				
VY	V <sub>OH</sub> – 0.3 V	V <sub>OH</sub> – 0.15 V	V <sub>OH</sub> – 0.15 V				

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2006-02-01



# **Package Dimensions**



Weight: 0.25 g (typ.)

Note: Lead (Pb)-Free Packages

TSSOP48-P-0061-0.50

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20070701-EN

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